

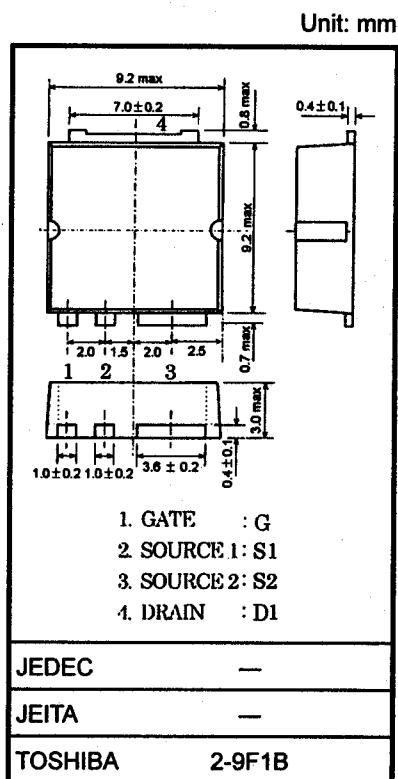
TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOSV)**2SK3443**

Switching Regulator, DC-DC Converter and Motor Drive Applications

- Low drain-source ON resistance:  $R_{DS(ON)} = 50 \text{ m}\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 9 \text{ S}$  (typ.)
- Low leakage current:  $IDSS = 100 \mu\text{A}$  ( $V_{DS} = 150 \text{ V}$ )
- Enhancement-mode:  $V_{th} = 3.0 \text{ to } 5.0 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $ID = 1 \text{ mA}$ )

**Maximum Ratings ( $T_a = 25^\circ\text{C}$ )**

Characteristics	Symbol	Rating	Unit
Drain-source voltage	$V_{DSS}$	150	V
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )	$V_{DGR}$	150	V
Gate-source voltage	$V_{GSS}$	$\pm 30$	V
Drain current	DC	$I_D$	30
	Pulse	$I_{DP}$	120
Drain power dissipation ( $T_c = 25^\circ\text{C}$ )	$P_D$	125	W
Single pulse avalanche energy**	$E_{AS}$	468	mJ
Avalanche current	$I_{AR}$	30	A
Repetitive avalanche energy*	$E_{AR}$	12.5	mJ
Channel temperature	$T_{ch}$	150	$^\circ\text{C}$
Storage temperature range	$T_{stg}$	-55 to 150	$^\circ\text{C}$



Weight: 0.74 g (typ.)

**Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	$R_{th}(ch-c)$	1.00	$^\circ\text{C}/\text{W}$

## Note 1:

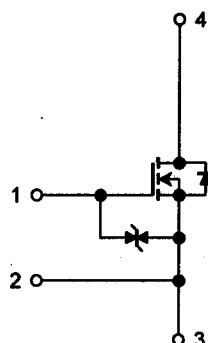
- \* Repetitive rating; pulse width limited by max channel temperature.
- \*\*  $V_{DD} = 50 \text{ V}$ ,  $T_{ch} = 25^\circ\text{C}$  (initial),  $L = 773 \mu\text{H}$ ,  $R_G = 25 \Omega$ ,  $I_{AR} = 30 \text{ A}$

This transistor is an electrostatic sensitive device.

Please handle with caution.

## Notice:

Please use the S1 pin for gate input signal return. Make sure that the main current flows into S2 pin.



Electrical Characteristics (Note 2) ( $T_a = 25^\circ C$ )

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	$I_{GSS}$	$V_{GS} = \pm 25 V, V_{DS} = 0 V$	—	—	$\pm 10$	$\mu A$
Drain cut-off current	$I_{DSS}$	$V_{DS} = 150 V, V_{GS} = 0 V$	—	—	100	$\mu A$
Drain-source breakdown voltage	$V_{(BR) DSS}$	$I_D = 10 mA, V_{GS} = 0 V$	150	—	—	V
Gate threshold voltage	$V_{th}$	$V_{DS} = 10 V, I_D = 1 mA$	3.0	—	5.0	V
Drain-source ON resistance	$R_{DS (ON)}$	$V_{GS} = 10 V, I_D = 15 A$	—	50	55	$m\Omega$
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 10 V, I_D = 15 A$	4.5	9	—	S
Input capacitance	$C_{iss}$	$V_{DS} = 10 V, V_{GS} = 0 V, f = 1 MHz$	—	2030	—	pF
Reverse transfer capacitance	$C_{rss}$		—	340	—	pF
Output capacitance	$C_{oss}$		—	1200	—	pF
Switching time	Rise time	$t_r$	 $V_{GS1}$ : 0 V to 10 V	—	20	—
	Turn-on time	$t_{on}$		—	40	—
	Fall time	$t_f$		—	10	—
	Turn-off time	$t_{off}$		—	40	—
Total gate charge (gate-source plus gate-drain)	$Q_g$	$V_{DD} = 120 V, V_{GS} = 10 V, I_D = 30 A$	—	45	—	nC
Gate-source charge	$Q_{gs}$		—	21	—	nC
Gate-drain ("Miller") charge	$Q_{gd}$		—	24	—	nC

Note 2: Please connect the S1 pin and S2 pin, and then ground the connected pin.  
 (However, while switching times are measured, please don't connect and ground it.)

Source-Drain Diode Ratings and Characteristics (Note 3) ( $T_a = 25^\circ C$ )

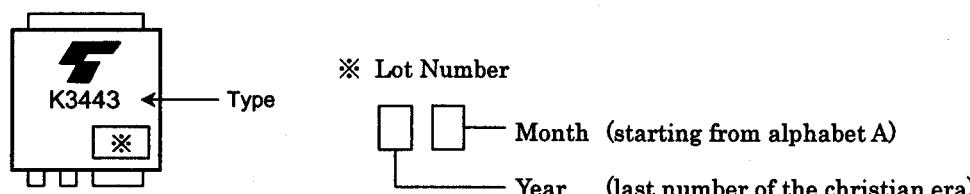
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current ***	$I_{DR1}$	—	—	—	30	A
Pulse drain reverse current ***	$I_{DRP1}$	—	—	—	120	A
Continuous drain reverse current ***	$I_{DR2}$	—	—	—	1	A
Pulse drain reverse current ***	$I_{DRP2}$	—	—	—	4	A
Diode forward voltage	$V_{DS2F}$	$I_{DR1} = 30 A, V_{GS} = 0 V$	—	—	-1.5	V
Reverse recovery time	$t_{rr}$	$I_{DR} = 30 A, V_{GS} = 0 V,$ $dI_{DR}/dt = 100 A/\mu s$	—	250	—	ns
Reverse recovery charge	$Q_{rr}$		—	1.75	—	$\mu C$

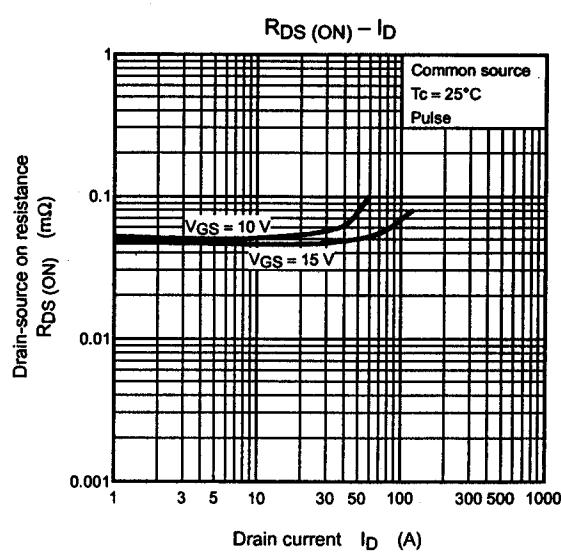
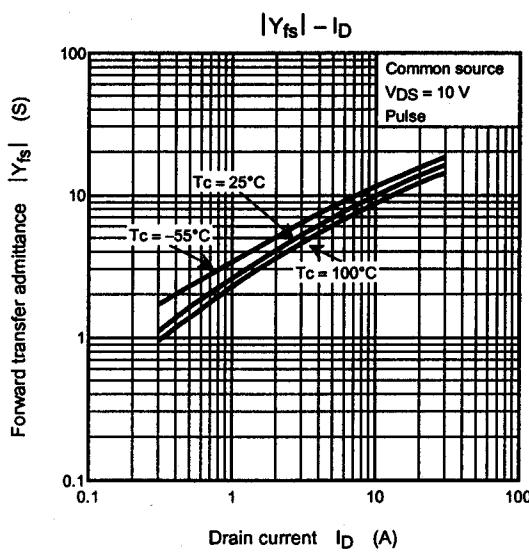
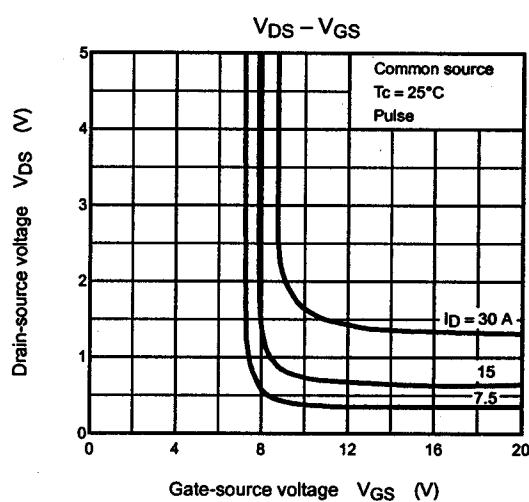
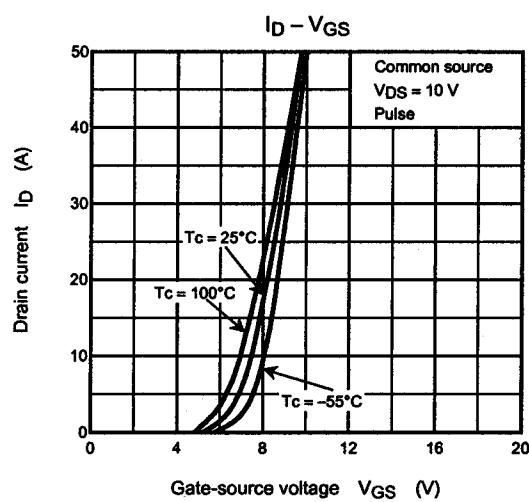
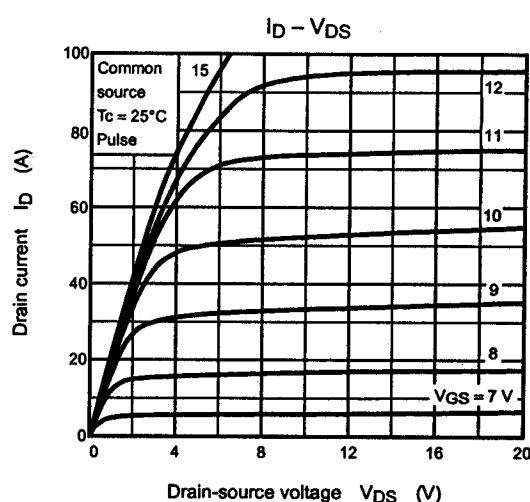
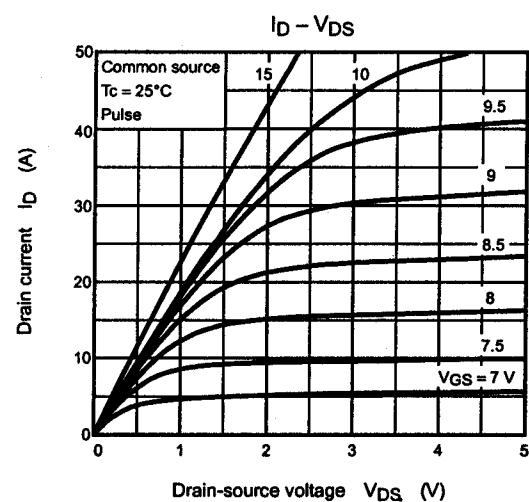
Note 3:

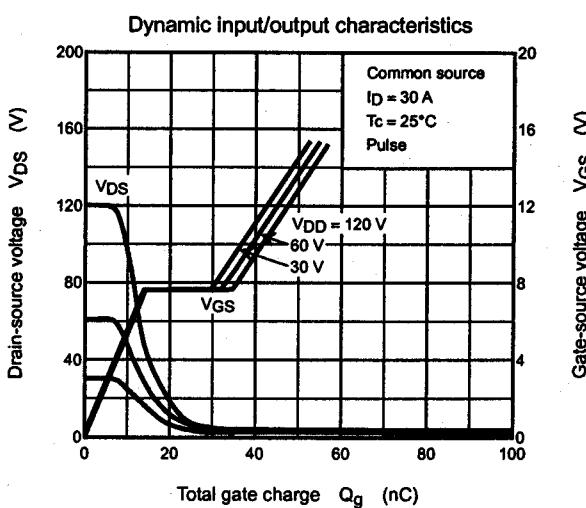
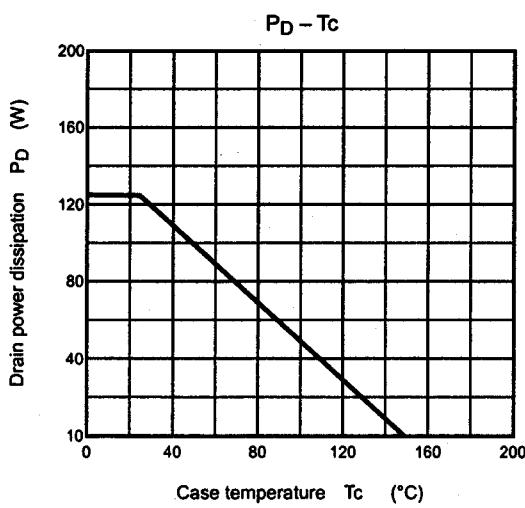
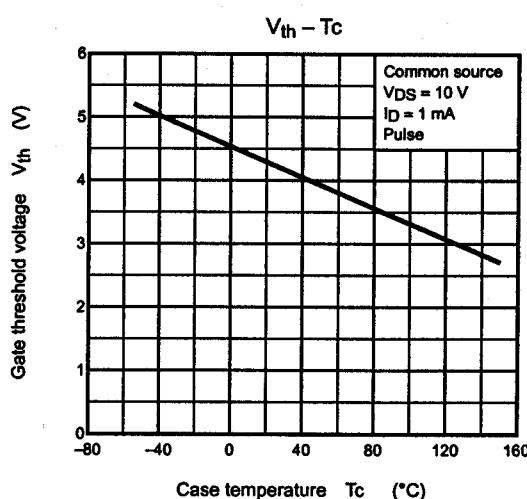
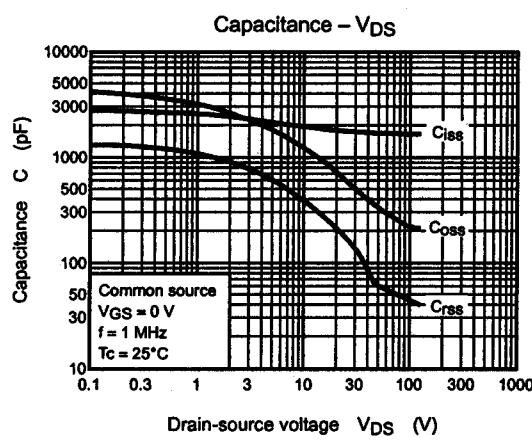
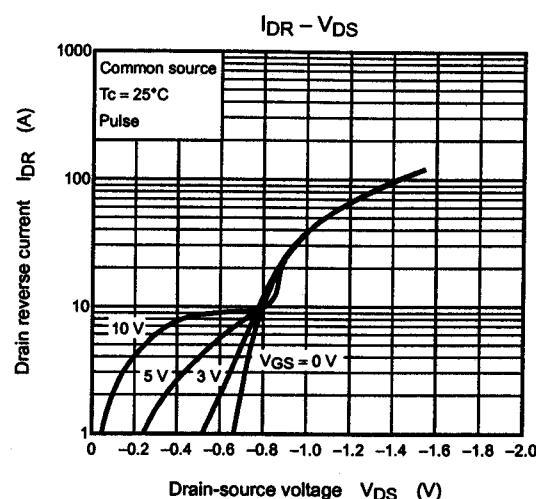
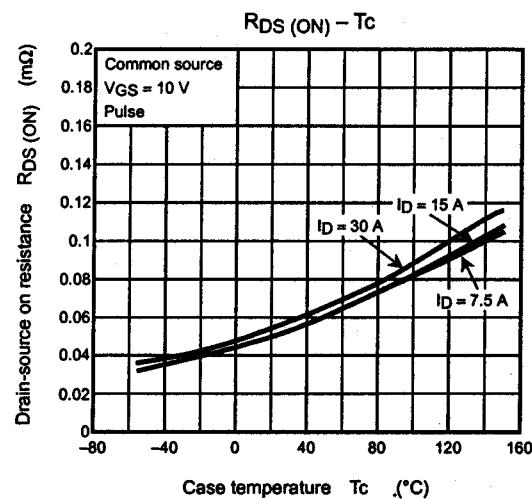
\*\*\* drain, flowing current value between the S2 pin, open the S1 pin  
 drain, flowing current value between the S1 pin, open the S2 pin

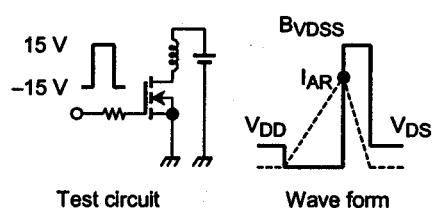
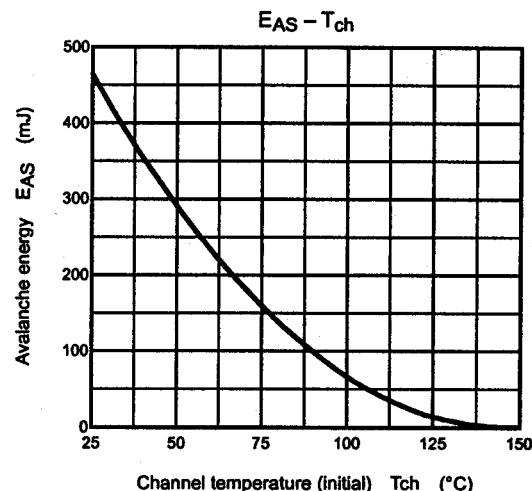
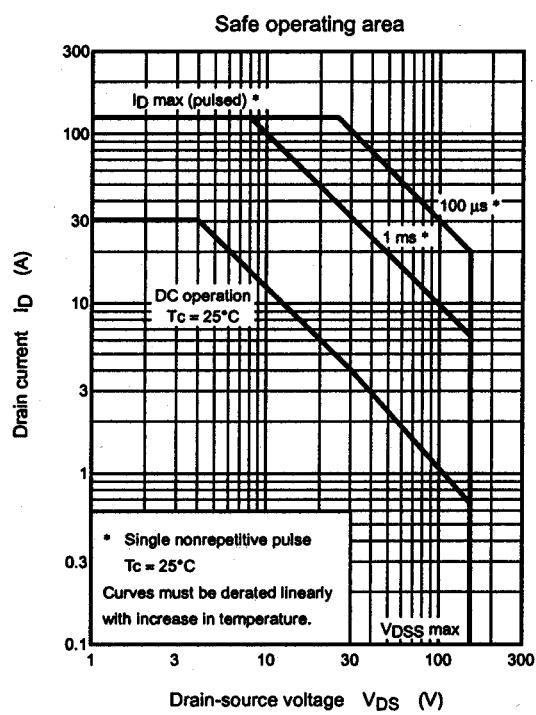
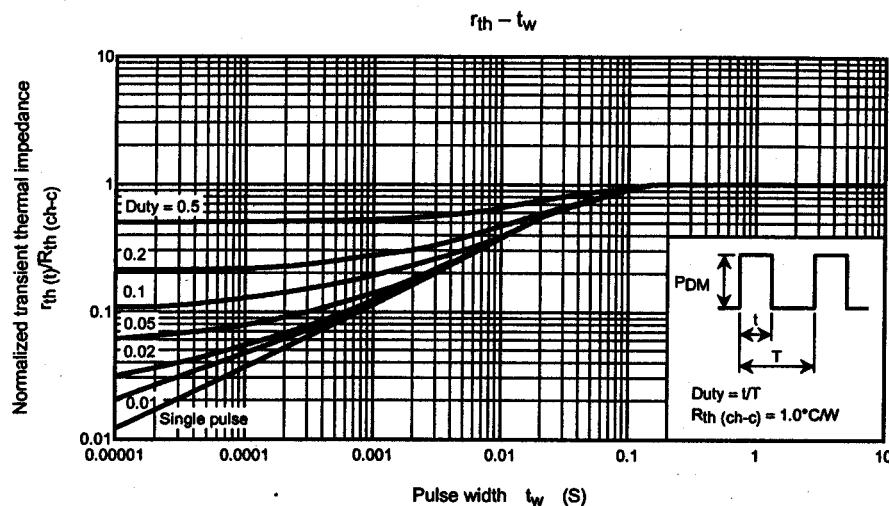
Unless otherwise specified, please connect the S1 and S2 pins, and then ground the connected pin.

## Marking









$$R_G = 25 \Omega$$

$$V_{DD} = 50 \text{ V}, L = 773 \mu\text{H}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BVDSS}{BVDSS - V_{DD}} \right)$$